

MOSFETs Silicon N-channel MOS (U-MOSIX-H)

# TPW1R005PL

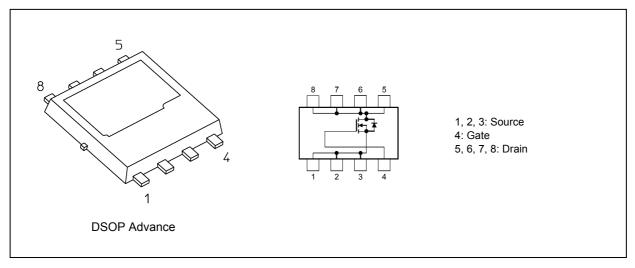
#### 1. Applications

- · High-Efficiency DC-DC Converters
- · Switching Voltage Regulators
- · Motor Drivers

#### 2. Features

- (1) High-speed switching
- (2) Small gate charge:  $Q_{SW} = 34 \text{ nC (typ.)}$
- (3) Small output charge:  $Q_{oss} = 98 \text{ nC (typ.)}$
- (4) Low drain-source on-resistance:  $R_{DS(ON)} = 0.75 \text{ m}\Omega$  (typ.) ( $V_{GS} = 10 \text{ V}$ )
- (5) Low leakage current:  $I_{DSS}$  = 10  $\mu A$  (max) ( $V_{DS}$  = 45 V)
- (6) Enhancement mode:  $V_{th} = 1.4 \text{ to } 2.4 \text{ V (V}_{DS} = 10 \text{ V}, I_D = 1.0 \text{ mA)}$

#### 3. Packaging and Internal Circuit





#### 4. Absolute Maximum Ratings (Note) (Ta = 25 °C unless otherwise specified)

Characteris	stics		Symbol	Rating	Unit
Drain-source voltage			$V_{DSS}$	45	V
Gate-source voltage			$V_{GSS}$	±20	
Drain current (DC)	( T <sub>c</sub> = 25 °C ) ( Bottom drain )	(Note 1)	I <sub>D</sub>	150	А
Drain current (DC)	( Silicon limit )	(Note 1), (Note 2)	I <sub>D</sub>	300	
Drain current (pulsed)	( t = 100 μs )	(Note 1)	I <sub>DP</sub>	500	
Power dissipation	( T <sub>c</sub> = 25 °C ) ( Bottom drain )		$P_D$	170	W
Power dissipation		(Note 3)	P <sub>D</sub>	3	
Power dissipation		(Note 4)	P <sub>D</sub>	0.96	
Single-pulse avalanche energy		(Note 5)	E <sub>AS</sub>	299	mJ
Single-pulse avalanche current		(Note 5)	I <sub>AS</sub>	120	Α
Channel temperature			T <sub>ch</sub>	175	℃
Storage temperature			T <sub>stg</sub>	-55 to 175	

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

#### 5. Thermal Characteristics

Characteristics	Symbol	Max	Unit		
Channel-to-case thermal resistance	Bottom drain ( T <sub>c</sub> = 25 °C )		R <sub>th(ch-c)</sub>	0.88	°C/W
Channel-to-case thermal resistance	Top source ( T <sub>c</sub> = 25 °C )		R <sub>th(ch-c)</sub>	0.93	
Channel-to-ambient thermal resistance	( T <sub>a</sub> = 25 °C )	(Note 3)	R <sub>th(ch-a)</sub>	50	
Channel-to-ambient thermal resistance	( T <sub>a</sub> = 25 °C )	(Note 4)	R <sub>th(ch-a)</sub>	156	

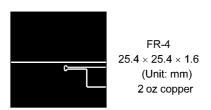
Note 1: Ensure that the channel temperature does not exceed 175 °C.

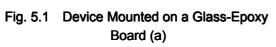
Note 2: Limited 150 A by package capability.

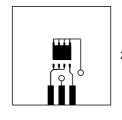
Note 3: Device mounted on a glass-epoxy board (a), Figure 5.1

Note 4: Device mounted on a glass-epoxy board (b), Figure 5.2

Note 5:  $V_{DD}$  = 36 V,  $T_{ch}$  = 25 °C (initial), L = 16  $\mu$ H,  $I_{AS}$  = 120 A







FR-4  $25.4 \times 25.4 \times 1.6$  (Unit: mm) 2 oz copper

Fig. 5.2 Device Mounted on a Glass-Epoxy Board (b)

Note: This transistor is sensitive to electrostatic discharge and should be handled with care.



#### 6. Electrical Characteristics

# 6.1. Static Characteristics (T<sub>a</sub> = 25 °C unless otherwise specified)

Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage current	I <sub>GSS</sub>	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$	_	_	±0.1	μΑ
Drain cut-off current	I <sub>DSS</sub>	V <sub>DS</sub> = 45 V, V <sub>GS</sub> = 0 V	_	_	10	
Drain-source breakdown voltage	V <sub>(BR)DSS</sub>	I <sub>D</sub> = 10 mA, V <sub>GS</sub> = 0 V	45	_	_	V
Drain-source breakdown voltage (Note 6)	V <sub>(BR)DSX</sub>	I <sub>D</sub> = 10 mA, V <sub>GS</sub> = -20 V	30	_	_	
Gate threshold voltage	$V_{th}$	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 1.0 mA	1.4	_	2.4	
Drain-source on-resistance	R <sub>DS(ON)</sub>	V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 50 A	_	1.15	1.65	mΩ
		V <sub>GS</sub> = 10 V, I <sub>D</sub> = 50 A		0.75	0.99	

Note 6: If a reverse bias is applied between gate and source, this device enters  $V_{(BR)DSX}$  mode. Note that the drain-source breakdown voltage is lowered in this mode.

#### 6.2. Dynamic Characteristics (T<sub>a</sub> = 25 °C unless otherwise specified)

Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Input capacitance	C <sub>iss</sub>	V <sub>DS</sub> = 22.5 V, V <sub>GS</sub> = 0 V, f = 1 MHz	_	7700	9600	pF
Reverse transfer capacitance	C <sub>rss</sub>		_	76	_	
Output capacitance	C <sub>oss</sub>		_	1860	_	
Gate resistance	r <sub>g</sub>	_	_	0.6	1.1	Ω
Switching time (rise time)	t <sub>r</sub>	See Fig. 6.2.1	_	17	_	ns
Switching time (turn-on time)	t <sub>on</sub>		_	29	_	
Switching time (fall time)	t <sub>f</sub>		_	18	_	
Switching time (turn-off time)	t <sub>off</sub>		_	75	_	

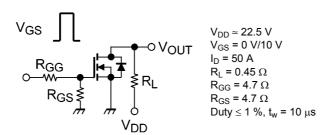


Fig. 6.2.1 Switching Time Test Circuit

# 6.3. Gate Charge Characteristics (T<sub>a</sub> = 25 °C unless otherwise specified)

Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Total gate charge (gate-source plus	$Q_g$	$V_{DD} \approx 22.5 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 50 \text{ A}$	_	122	1	nC
gate-drain)		$V_{DD} \approx 22.5 \text{ V}, V_{GS} = 4.5 \text{ V}, I_D = 50 \text{ A}$	_	59		
Gate-source charge 1	Q <sub>gs1</sub>	$V_{DD} \approx 22.5 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 50 \text{ A}$	_	30		
Gate-drain charge	$Q_{gd}$		_	22		
Gate switch charge	$Q_{SW}$		_	34	_	
Output charge	$Q_{oss}$	V <sub>DS</sub> = 22.5 V, V <sub>GS</sub> = 0 V, f = 1 MHz	_	98		

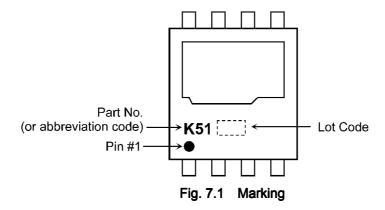


# 6.4. Source-Drain Characteristics ( $T_a = 25$ °C unless otherwise specified)

Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Reverse drain current (pulsed) (Note 7)	I <sub>DRP</sub>	( t = 100 μs )	_	_	500	Α
Diode forward voltage	V <sub>DSF</sub>	I <sub>DR</sub> = 150 A, V <sub>GS</sub> = 0 V	1	_	-1.2	V
Reverse recovery time		V <sub>R</sub> = 22.5 V, I <sub>DR</sub> = 37.5 A, V <sub>GS</sub>		58	_	ns
Reverse recovery charge	Q <sub>rr</sub>	= 0 V, -dI <sub>DR</sub> /dt = 100 A/μs	1	66		nC

Note 7: Ensure that the channel temperature does not exceed 175  $^{\circ}\text{C}$ .

# 7. Marking





#### 8. Characteristics Curves (Note)

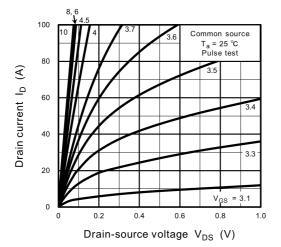


Fig. 8.1 I<sub>D</sub> - V<sub>DS</sub>

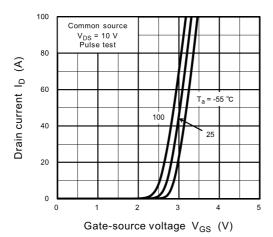


Fig. 8.3 I<sub>D</sub> - V<sub>GS</sub>

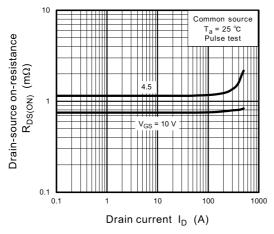


Fig. 8.5 R<sub>DS(ON)</sub> - I<sub>D</sub>

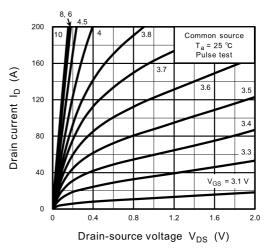


Fig. 8.2 I<sub>D</sub> - V<sub>DS</sub>

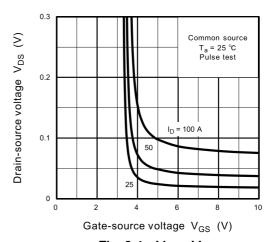


Fig. 8.4 V<sub>DS</sub> - V<sub>GS</sub>

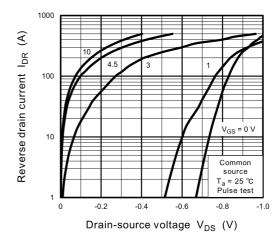


Fig. 8.6 IDR - VDS



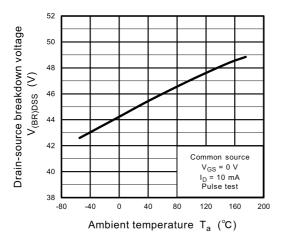


Fig. 8.7 V<sub>(BR)DSS</sub> - T<sub>a</sub>

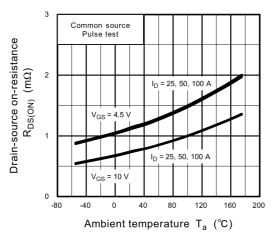


Fig. 8.9 R<sub>DS(ON)</sub> - T<sub>a</sub>

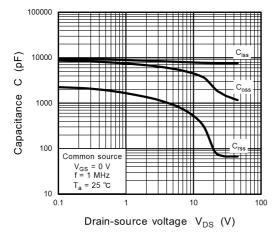


Fig. 8.11 Capacitance - V<sub>DS</sub>

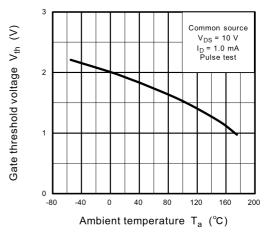


Fig. 8.8 V<sub>th</sub> - T<sub>a</sub>

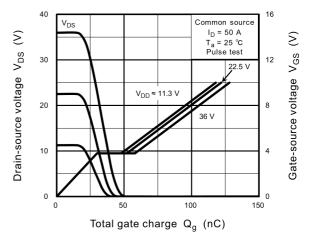


Fig. 8.10 Dynamic Input/Output Characteristics

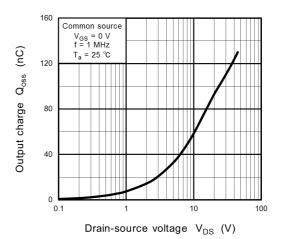


Fig. 8.12 Qoss - VDS



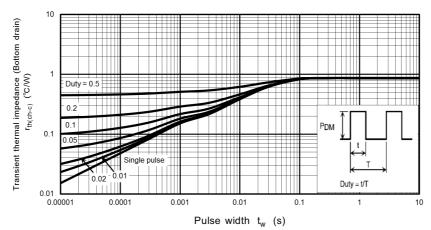


Fig. 8.13 r<sub>th</sub> - t<sub>w</sub> (Bottom drain) (Guaranteed Maximum)

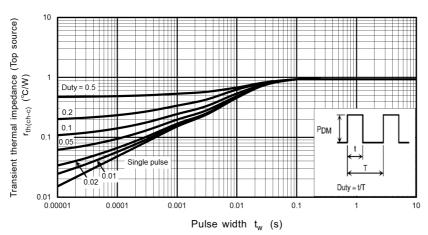


Fig. 8.14 r<sub>th</sub> - t<sub>w</sub> (Top source) (Guaranteed Maximum)

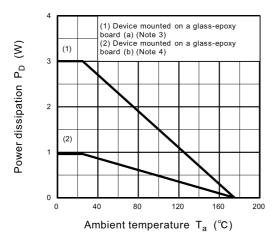


Fig. 8.15 P<sub>D</sub> - T<sub>a</sub> (Guaranteed Maximum)

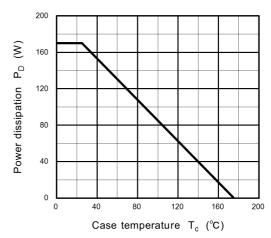


Fig. 8.16 P<sub>D</sub> - T<sub>c</sub> (Bottom drain) (Guaranteed Maximum)



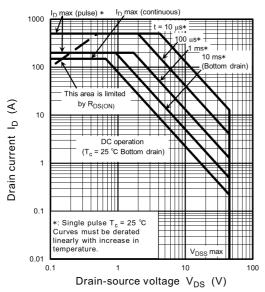


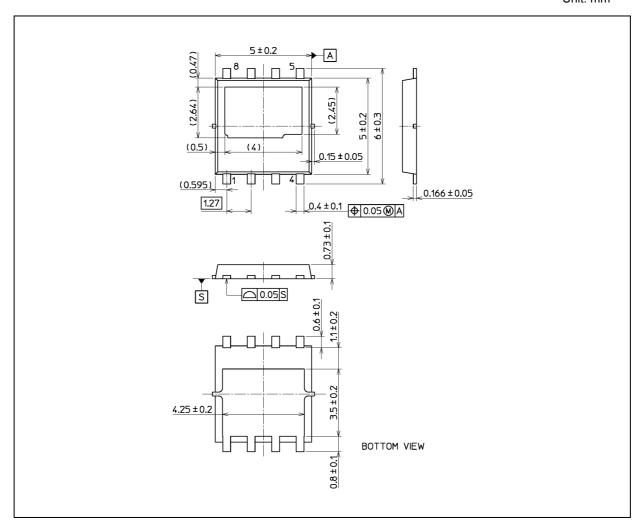
Fig. 8.17 Safe Operating Area (Guaranteed Maximum)

Note: The above characteristics curves are presented for reference only and not guaranteed by production test, unless otherwise noted.



# **Package Dimensions**

Unit: mm



Weight: 0.104 g (typ.)

Package Name(s)
TOSHIBA: 2-5S1A
Nickname: DSOP Advance

Rev.2.0



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